

October 1987 Revised January 1999

### **CD4503BC**

## **Hex Non-Inverting 3-STATE Buffer**

#### **General Description**

The CD4503BC is a hex non-inverting 3-STATE buffer with high output current sink and source capability. 3-STATE outputs make it useful in bus-oriented applications. Two separate disable inputs are provided. Buffers 1 through 4 are controlled by the disable 4 input. Buffers 5 and 6 are controlled by the disable 2 input. A high level on either disable input will cause those gates on its control line to go into a high impedance state.

#### **Features**

- Wide supply voltage range:  $3.0 \text{ V}_{DC}$  to  $18 \text{ V}_{DC}$
- 3-STATE outputs
- Symmetrical turn on/turn off delays
- Symmetrical output rise and fall times
- Pin-for-pin replacement for MM80C97 and MC14503

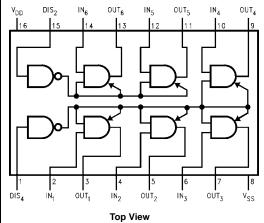
#### **Ordering Code:**

Order Number	Package Number	Package Description				
CD4503BCM	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Body				
CD4503BCSJ	M16D	16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide				
CD4503BCN	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide				

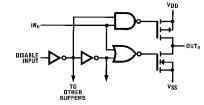
Devices also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

#### **Connection Diagram**

#### Pin Assignments for DIP, SOIC and SOP



### **Schematic Diagram**



#### **Truth Table**

In	Disable	Out
	Input	
0	0	0
1	0	1
Х	1	3-STATE

X = Don't Care

#### Absolute Maximum Ratings(Note 1)

(Note 2)

Recommended Operating Conditions (Note 2)

Supply Voltage ( $V_{DD}$ ) -0.5V to +18V

Input Voltage (V<sub>IN</sub>) -0.5V to +0.5V

Storage Temperature Range ( $T_S$ )  $-65^{\circ}C$  to  $+150^{\circ}C$ 

Power Dissipation (P<sub>D</sub>)

Dual-In-Line 700 mW Small Outline 500 mW

Lead Temperature (T<sub>L</sub>)

(Soldering, 10 seconds) 260°C

Supply Voltage ( $V_{DD}$ ) +3V to +15V Operating Temperature Range ( $T_A$ ) -40°C to +85°C

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Recommended Operating Conditions" and "Electrical Characteristics" provide conditions for actual device operation.

Note 2:  $V_{SS} = 0V$  unless otherwise specified.

#### DC Electrical Characteristics (Note 2)

Symbol	Parameter	Conditions	-40	-40°C		+25°C		+ <b>85°C</b>		Units
			Min	Max	Min	Тур	Max	Min	Max	Units
I <sub>DD</sub>	Quiescent Device	$V_{DD} = 5V$ ,		4			4		30	μΑ
	Current	$V_{IN} = V_{DD}$ or $V_{SS}$								
		$V_{DD} = 10V$ ,		8			8		60	μΑ
		$V_{IN} = V_{DD}$ or $V_{SS}$								
		$V_{DD} = 15V$ ,		16			16		120	μΑ
		$V_{IN} = V_{DD}$ or $V_{SS}$								
V <sub>OL</sub>	LOW Level	$V_{IN} = V_{DD}$ or 0								
	Output Voltage	$V_{DD} = 5V$		0.05		0	0.05		0.05	V
		$V_{DD} = 10V$		0.05		0	0.05		0.05	V
		$V_{DD} = 15V$		0.05		0	0.05		0.05	V
V <sub>OH</sub>	HIGH Level	V <sub>IN</sub> = V <sub>DD</sub> or 0								
	Output Voltage	$V_{DD} = 5V$	4.95		4.95			4.95		V
		$V_{DD} = 10V$	9.95		9.95			9.95		V
		V <sub>DD</sub> = 15V	14.95		14.95			14.95		V
V <sub>IL</sub>	LOW Level	V <sub>DD</sub> = 5V,		1.5		2.25	1.5		1.5	V
	Input Voltage	V <sub>O</sub> = 4.5V or 0.5V								
		V <sub>DD</sub> = 10V,		3.0		4.50	3.0		3.0	V
		V <sub>O</sub> = 9.0V or 1.0V								
		V <sub>DD</sub> = 15V,		4.0		6.75	4.0		4.0	V
		V <sub>O</sub> = 13.5V or 1.5V								
V <sub>IH</sub>	HIGH Level	V <sub>DD</sub> = 5V,	3.5		3.5	2.75		3.5		V
	Input Voltage	V <sub>O</sub> = 0.5V or 4.5V								
		V <sub>DD</sub> = 10V,	7.0		7.0	5.5		7.0		V
		V <sub>O</sub> = 1.0V or 9.0V								
		V <sub>DD</sub> = 15V,	11.0		11.0	8.25		11.0		V
		V <sub>O</sub> = 1.5V or 13.5V								
I <sub>OL</sub>	LOW Level Output	V <sub>DD</sub> = 4.5V, V <sub>OL</sub> = 0.4V	2.30		1.95	2.65		1.60		mA
	Current	$V_{DD} = 5.0V, V_{OL} = 0.4V$	2.5		2.10	2.75		1.75		mA
		$V_{DD} = 10V, V_{OL} = 0.5V$	6.5		5.45	7.0		4.45		mA
		$V_{DD} = 15V, V_{OL} = 1.5V$	16.50		13.80	25.00		11.30		mA
I <sub>OH</sub>	HIGH Level Output	V <sub>DD</sub> = 5V, V <sub>OH</sub> = 4.6V	-1.04		-0.88	-1.76		-0.7		mA
	Current	$V_{DD} = 10V, V_{OH} = 9.5V$	-2.60		-2.2	-4.50		-1.8		mA
		V <sub>DD</sub> = 15V, V <sub>OH</sub> = 13.5V	-7.2		-6.0	-17.6		-4.8		mA
I <sub>TL</sub>	3-STATE Leakage Current	V <sub>DD</sub> = 15V		±0.3		±10 <sup>-4</sup>	±0.3		±1.0	μΑ
I <sub>IN</sub>	Input Current	V <sub>DD</sub> = 15V		±0.3		±10 <sup>-5</sup>	±0.3		±1.0	μA

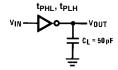
Note 3: I<sub>OH</sub> and I<sub>OL</sub> are tested one output at a time.

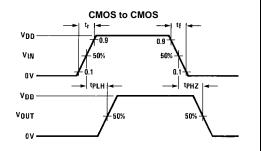
# AC Electrical Characteristics (Note 4) $T_A = 25\,^{\circ}\text{C}, \ C_L = 50 \ \text{pF}, \ R_L = 200 \ \text{k}\Omega, \ \text{Input } t_r = t_f = 20 \ \text{ns}, \ \text{unless otherwise specified}$

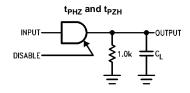
Symbol	Parameter	Conditions	Min	Тур	Max	Units
t <sub>PHL</sub> , t <sub>PLH</sub>	Propagation Delay Time	$V_{DD} = 5V$		75	100	ns
		$V_{DD} = 10V$		35	40	ns
		$V_{DD} = 15V$		25	30	ns
$t_{PLZ}$ , $t_{PHZ}$	Propagation Delay Time,	$V_{DD} = 5V$		80	125	ns
	Logical Level to HIGH	$V_{DD} = 10V$		40	90	ns
	Impedance State	$V_{DD} = 15V$		35	70	ns
$t_{PZL}$ , $t_{PZH}$	Propagation Delay Time,	$V_{DD} = 5V$		95	175	ns
	High Impedance State to	$V_{DD} = 10V$		40	80	ns
	Logical Level	$V_{DD} = 15V$		35	70	ns
t <sub>TLH</sub>	Output Rise Time	$V_{DD} = 5V$		45	80	ns
		$V_{DD} = 10V$		23	40	ns
		$V_{DD} = 15V$		18	35	ns
t <sub>THL</sub>	Output Fall Time	$V_{DD} = 5V$		45	80	ns
		$V_{DD} = 10V$		23	40	ns
		$V_{DD} = 15V$		18	35	ns

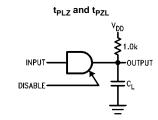
Note 4: AC Parameters are guaranteed by DC correlated testing.

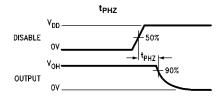
## **AC Test Circuits and Switching Time Waveforms**

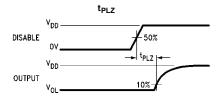


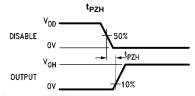


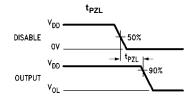


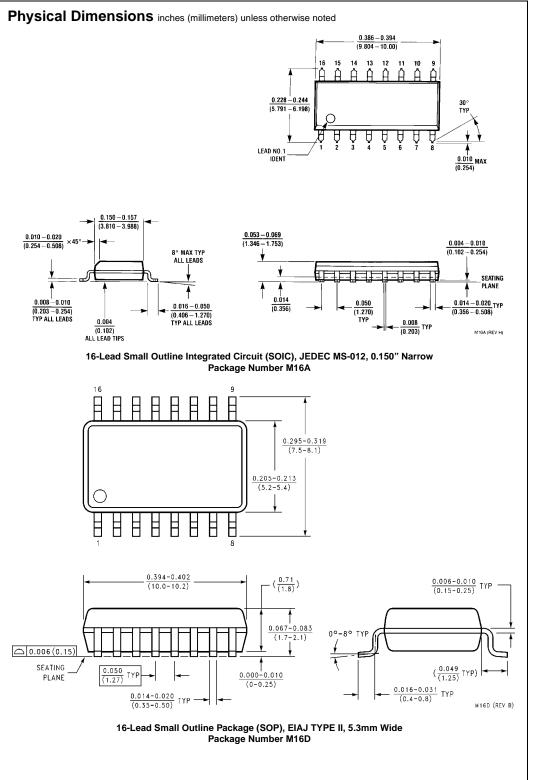




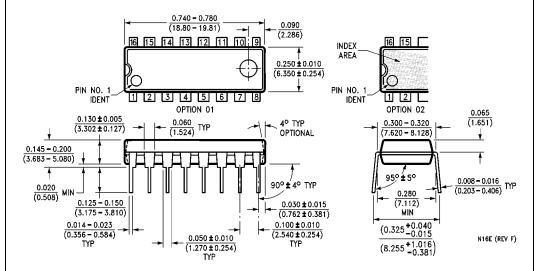








#### Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N16E

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